



YOUSHANG SEMICONDUCTOR

**设计研发新型功率器件**

**各类小信号开关**

**中低压及高压大电流等场效应管**

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企业微信二维码



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## Product Summary

BV <sub>DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX T <sub>A</sub> = +25°C
30V	38mΩ @ V <sub>GS</sub> = 10V	5.8A
	64mΩ @ V <sub>GS</sub> = 4.5V	4.5A

## Description

This new generation MOSFET is designed to minimize the on-state resistance (R<sub>DS(ON)</sub>) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

## Applications

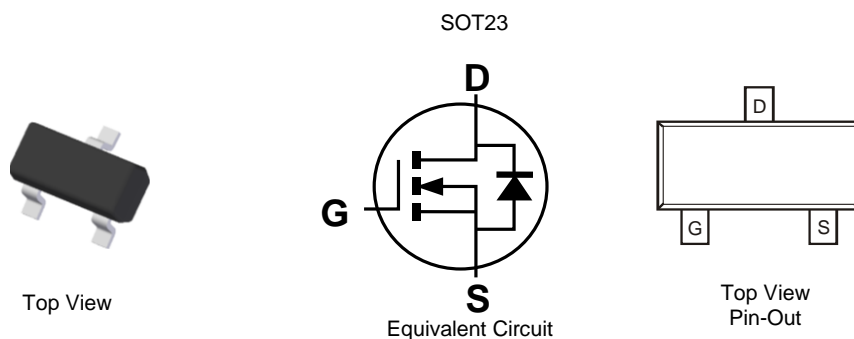
- Load Switch
- DC-DC Converters
- Power Management Functions

## Features and Benefits

- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage

## Mechanical Data

- Case: SOT23
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish – Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 Ⓔ3
- Terminal Connections: See Diagram
- Weight: 0.008 grams (Approximate)



**Maximum Ratings** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Drain-Source Voltage		$V_{DSS}$	30	V
Gate-Source Voltage		$V_{GSS}$	$\pm 20$	V
Continuous Drain Current (Note 6) $V_{GS} = 10\text{V}$	Steady State	$T_A = +25^\circ\text{C}$	4.5	A
		$T_A = +70^\circ\text{C}$	3.5	
	$t < 5\text{s}$	$T_A = +25^\circ\text{C}$	5.8	A
		$T_A = +70^\circ\text{C}$	4.9	
Pulsed Drain Current (10 $\mu\text{s}$ Pulse, Duty Cycle = 1%)		$I_{DM}$	20	A
Maximum Body Diode Forward Current (Note 6)		$I_S$	2	A

**Thermal Characteristics**

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	$T_A = +25^\circ\text{C}$	$P_D$	0.7	W
	$T_A = +70^\circ\text{C}$		0.44	
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{\theta JA}$	182	$^\circ\text{C/W}$
	$t < 5\text{s}$		109	
Total Power Dissipation (Note 6)	$T_A = +25^\circ\text{C}$	$P_D$	1.4	W
	$T_A = +70^\circ\text{C}$		0.85	
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{\theta JA}$	94	$^\circ\text{C/W}$
	$t < 5\text{s}$		56	
Thermal Resistance, Junction to Case (Note 6)		$R_{\theta JC}$	25	
Operating and Storage Temperature Range		$T_J, T_{STG}$	-55 to +150	$^\circ\text{C}$

**Electrical Characteristics** (@ $T_A = +25^\circ\text{C}$ , unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS (Note 7)</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	30	—	—	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
Zero Gate Voltage Drain Current	$I_{DSS}$	—	—	800	nA	$V_{DS} = 28\text{V}, V_{GS} = 0\text{V}$
Gate-Body Leakage	$I_{GSS}$	—	—	$\pm 80$	nA	$V_{GS} = \pm 12\text{V}, V_{DS} = 0\text{V}$
				$\pm 800$		$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$
<b>ON CHARACTERISTICS (Note 7)</b>						
Gate Threshold Voltage	$V_{GS(TH)}$	1.3	1.9	2.2	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
Static Drain-Source On-Resistance	$R_{DS(ON)}$	—	33	38	m $\Omega$	$V_{GS} = 10\text{V}, I_D = 5.8\text{A}$
			54	64		$V_{GS} = 4.5\text{V}, I_D = 5.0\text{A}$
Forward Transconductance	$ Y_{fs} $	—	5	—	S	$V_{DS} = 5\text{V}, I_D = 3.1\text{A}$
Source-Drain Diode Forward Voltage	$V_{SD}$	—	0.78	1.16	V	$V_{GS} = 0\text{V}, I_S = 2.0\text{A}$
<b>DYNAMIC CHARACTERISTICS (Note 8)</b>						
Input Capacitance	$C_{iss}$	—	424	—	pF	$V_{DS} = 5\text{V}, V_{GS} = 0\text{V}$ $f = 1.0\text{MHz}$
Output Capacitance	$C_{oss}$	—	115	—	pF	
Reverse Transfer Capacitance	$C_{rss}$	—	81	—	pF	
Gate Resistance	$R_g$	—	1.51	—	$\Omega$	$V_{DS} = 0\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$
Total Gate Charge	$Q_g$	—	9.0	—	nC	$V_{GS} = 10\text{V}, V_{DS} = 15\text{V}, I_D = 5.8\text{A}$
Gate-Source Charge	$Q_{gs}$	—	1.3	—	nC	
Gate-Drain Charge	$Q_{gd}$	—	1.3	—	nC	
Turn-On Delay Time	$t_{D(ON)}$	—	3.4	—	ns	$V_{DD} = 15\text{V}, V_{GS} = 10\text{V},$ $R_L = 2.6\Omega, R_g = 3\Omega$
Turn-On Rise Time	$t_R$	—	6.2	—	ns	
Turn-Off Delay Time	$t_{D(OFF)}$	—	13.9	—	ns	
Turn-Off Fall Time	$t_F$	—	2.8	—	ns	

- Notes:
- Device mounted on FR-4 PCB with minimum recommended pad layout, single sided.
  - Device mounted on 1" x 1" FR-4 PCB with high coverage 2 oz. Copper, single sided.
  - Short duration pulse test used to minimize self-heating effect.
  - Guaranteed by design. Not subject to production testing.

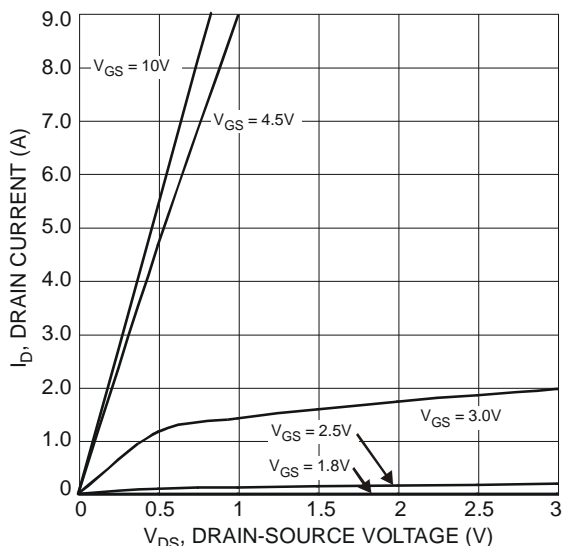


Fig. 1 Typical Output Characteristics

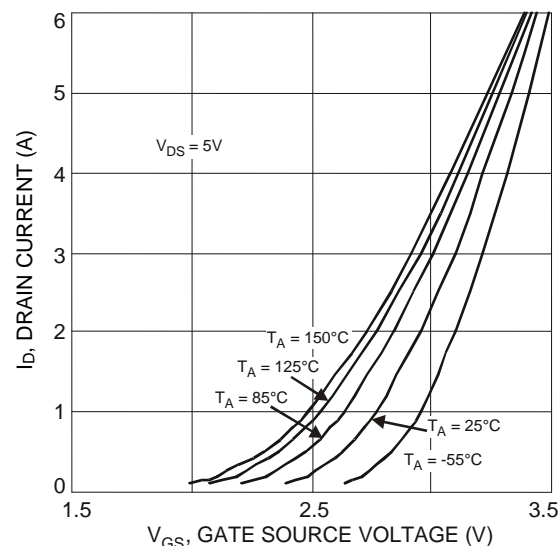


Fig. 2 Typical Transfer Characteristics

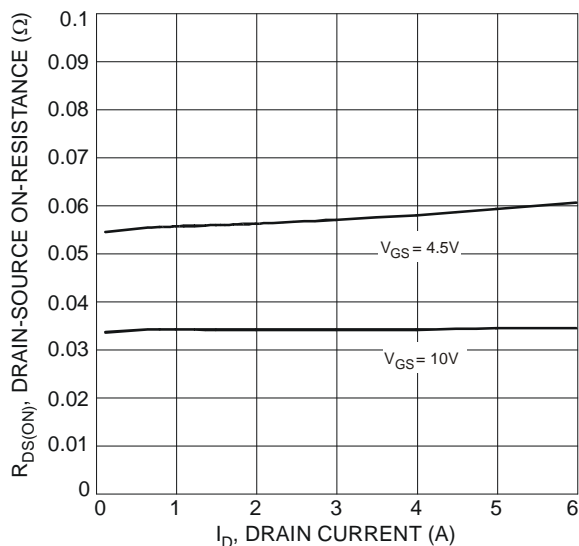


Fig. 3 Typical On-Resistance vs. Drain Current and Gate Voltage

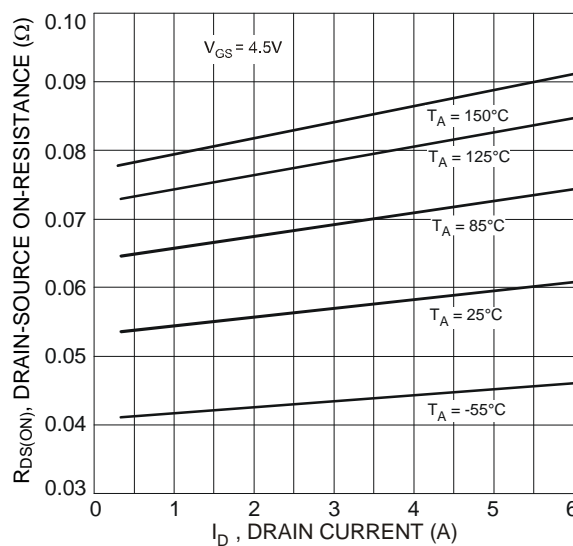


Fig. 4 Typical Drain-Source On-Resistance vs. Drain Current and Temperature

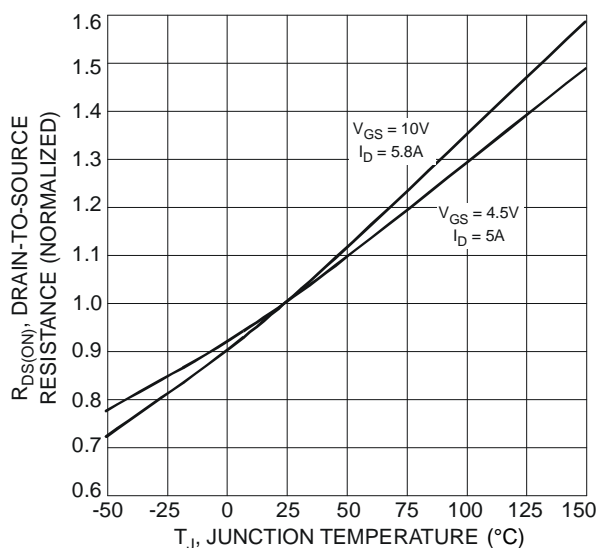


Fig. 5 On-Resistance Variation with Temperature

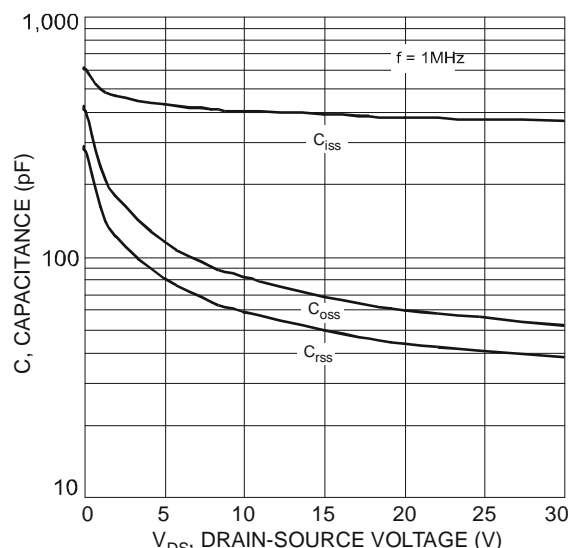


Fig. 6 Typical Capacitance

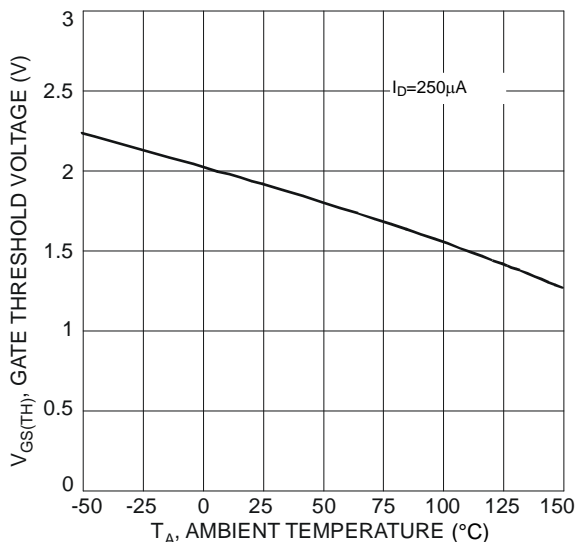


Fig. 7 Gate Threshold Variation vs. Ambient Temperature

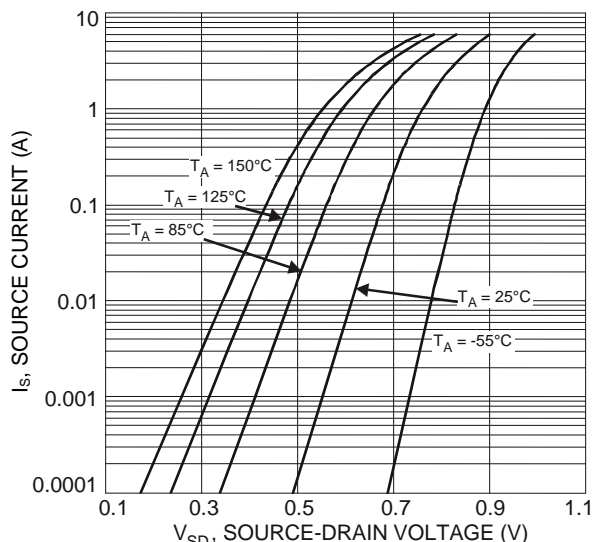


Fig. 8 Diode Forward Voltage vs. Current

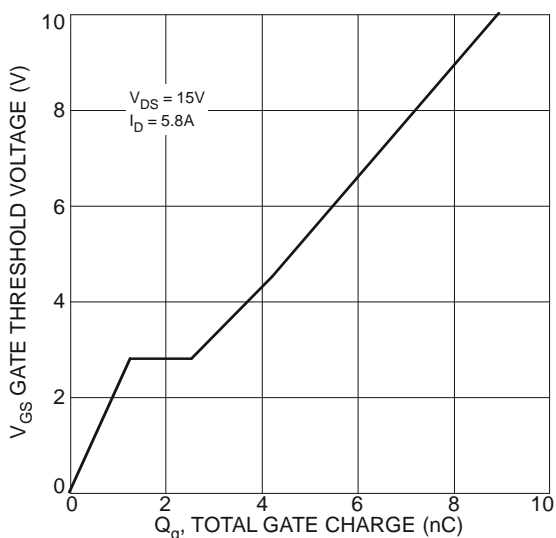


Fig. 9 Gate Charge

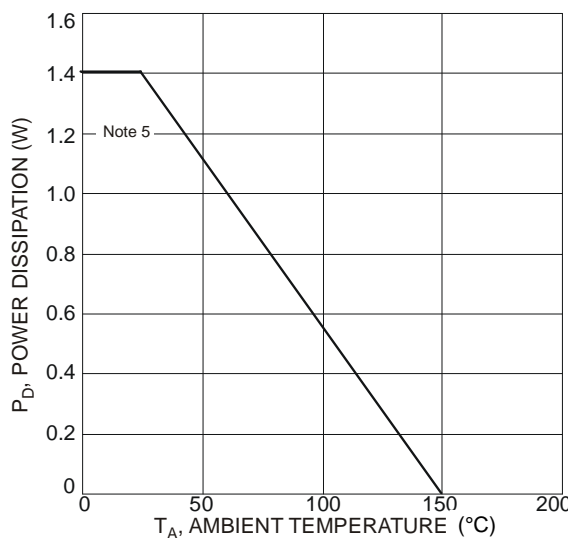


Fig. 10 Power Derating

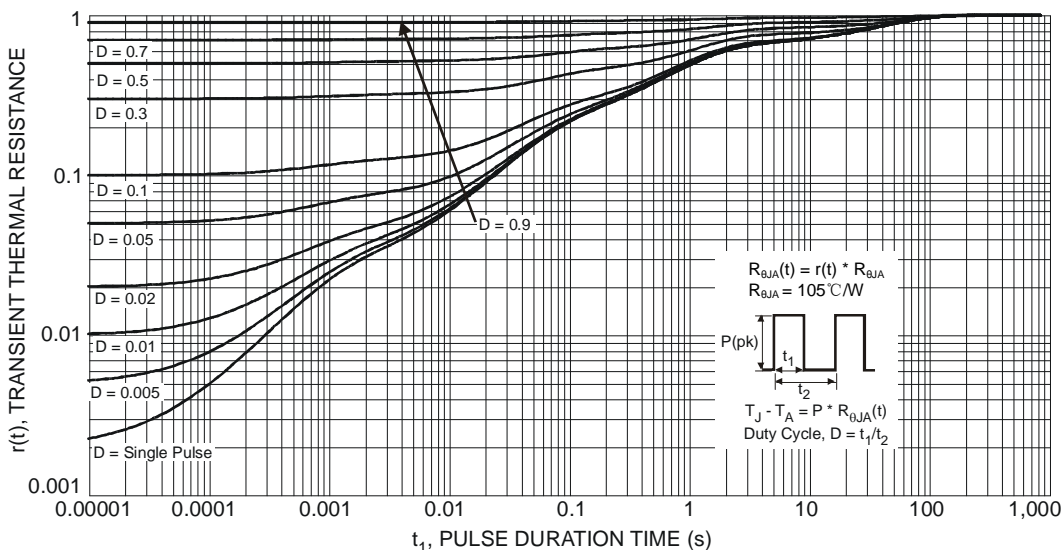
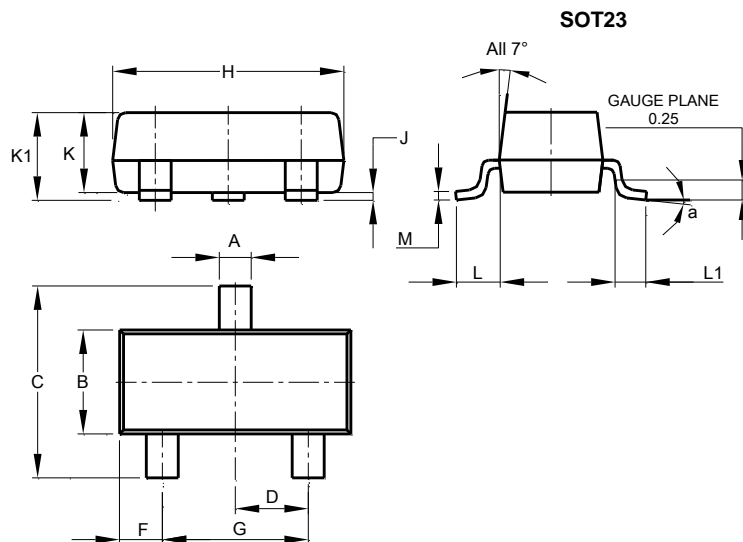


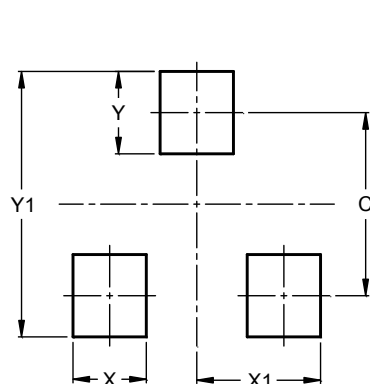
Fig. 11 Transient Thermal Response

## Package Outline Dimensions



SOT23			
Dim	Min	Max	Typ
A	0.37	0.51	0.40
B	1.20	1.40	1.30
C	2.30	2.50	2.40
D	0.89	1.03	0.915
F	0.45	0.60	0.535
G	1.78	2.05	1.83
H	2.80	3.00	2.90
J	0.013	0.10	0.05
K	0.890	1.00	0.975
K1	0.903	1.10	1.025
L	0.45	0.61	0.55
L1	0.25	0.55	0.40
M	0.085	0.150	0.110
a	0°	8°	--
All Dimensions in mm			

## Suggested Pad Layout



Dimensions	Value (in mm)
C	2.0
X	0.8
X1	1.35
Y	0.9
Y1	2.9